# **INTERNATIONAL STANDARD**

**ISO** 5577

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# No test. Essais non c. Non-destructive testing — Ultrasonic





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### **Foreword**

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The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see <a href="www.iso.org/directives">www.iso.org/directives</a>).

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ISO 5577 was prepared by the European Committee for Standardization (CEN) Technical Committee CEN/TC 138, *Non-destructive testing*, in collaboration with ISO Technical Committee TC 135, *Non-destructive testing*, Subcommittee SC 3, *Ultrasonic testing*, in accordance with the Agreement on technical cooperation between ISO and CEN (Vienna Agreement).

This second edition cancels and replaces the first edition (ISO 5577:2000), which has been technically revised with changes to terms and definitions and structure.

# Non-destructive testing — Ultrasonic testing — Vocabulary

### 1 Scope

This document defines the terms used in ultrasonic non-destructive testing and forms a common basis for standards and general use. This document does not cover terms used in ultrasonic testing with phased arrays.

NOTE Terms for phased array ultrasonic testing are defined in EN 16018.

### 2 Normative references

There are no normative references in this document.

## 3 Terms related to frequencies, waves and pulses

For the purposes of this document, the terms and definitions given in this clause and those given in Clauses 4, 5 and 6 for sound, test equipment and ultrasonic testing apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <a href="http://www.electropedia.org/">http://www.electropedia.org/</a>
- ISO Online browsing platform: available at <a href="http://www.iso.org/obp">http://www.iso.org/obp</a>

### 3.1 Frequencies

### 3.1.1

### frequency

number of cycles per second

Note 1 to entry: Expressed in Hertz (Hz).

### 3.1.2

### nominal frequency

probe frequency

frequency (3.1.1) of the probe (5.2.1) as stated by the manufacturer

### 3.1.3

## test frequency

effective ultrasonic frequency of a system used to test a material or object

### 3.1.4

### frequency spectrum

distribution of *amplitude* (3.2.2) in relation to *frequency* (3.1.1)

Note 1 to entry: See Figure 1.

### 3.1.5

### centre frequency

arithmetic mean of the cut-off frequencies

Note 1 to entry: See Figure 1.